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Rih Data Sheet

CONFIRMATION NO. 2216

SERIAL NUMB 09/903,601	= · · · · · · · · · · · · · · · · · · ·		CLASS 382		GROUP ART UNIT 2621			ATTORNEY DOCKET NO. S004-4330	
APPLICANTS Ryoichi Matsuoka, Chiba-shi, JAPAN;									
** FOREIGN APF JAPAN 200	PLICA 00-21	Now W Now W ATIONS ************************************	;c ****	ED					
7 St USC 119 (a-d) conditions					DRA	AWING CLAI		MS	INDEPENDENT CLAIMS 2
31st FLOOR 50 BROADWAY NEW YORK ,NY	ND CO	OUNSELORS AT LAW							
TITLE Semiconductor wafer pattern shape evaluation method and device									
RECEIVED	FEES: Authority has been given in Paper No to charge/credit DEPOSIT ACCOUNT No for following:				NT	All Fees 1.16 Fees (Filing) 1.17 Fees (Processing Ext. of time) 1.18 Fees (Issue) Other Credit			